

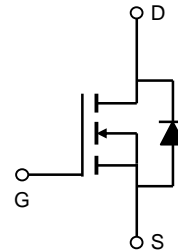
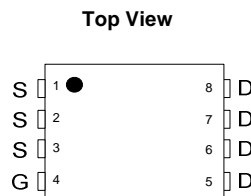
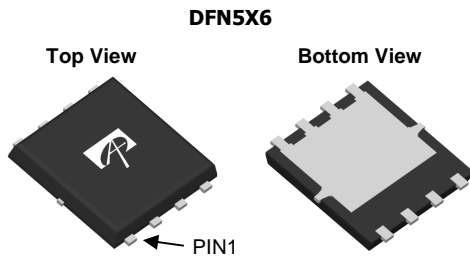
General Description

The AON6410 uses advanced trench technology to provide excellent $R_{DS(ON)}$, low gate charge. This device is suitable for use as a high side switch in SMPS and general purpose applications.

Product Summary

V_{DS} (V) = 30V
 I_D = 24A (V_{GS} = 10V)
 $R_{DS(ON)}$ < 12m Ω (V_{GS} = 10V)
 $R_{DS(ON)}$ < 14m Ω (V_{GS} = 4.5V)

100% UIS Tested
 100% Rg Tested



Absolute Maximum Ratings $T_A=25^\circ\text{C}$ unless otherwise noted

| Parameter | Symbol | Maximum | Units |
|---|----------------|-------------------------|------------------|
| Drain-Source Voltage | V_{DS} | 30 | V |
| Gate-Source Voltage | V_{GS} | ± 12 | V |
| Continuous Drain Current ^{BJ} | I_D | $T_C=25^\circ\text{C}$ | 24 |
| | | $T_C=100^\circ\text{C}$ | 19 |
| Pulsed Drain Current | I_{DM} | 120 | A |
| Continuous Drain Current ^H | I_{DSM} | $T_A=25^\circ\text{C}$ | 10 |
| | | $T_A=70^\circ\text{C}$ | 8 |
| Avalanche Current ^C | I_{AR} | 30 | A |
| Repetitive avalanche energy $L=0.3\text{mH}$ ^C | E_{AR} | 135 | mJ |
| Power Dissipation ^B | P_D | $T_C=25^\circ\text{C}$ | 35 |
| | | $T_C=100^\circ\text{C}$ | 14 |
| Power Dissipation ^A | P_{DSM} | $T_A=25^\circ\text{C}$ | 2 |
| | | $T_A=70^\circ\text{C}$ | 1.3 |
| Junction and Storage Temperature Range | T_J, T_{STG} | -55 to 150 | $^\circ\text{C}$ |

Thermal Characteristics

| Parameter | Symbol | Typ | Max | Units |
|--|-----------------|---------------------|-----|--------------------|
| Maximum Junction-to-Ambient ^A | $R_{\theta JA}$ | $t \leq 10\text{s}$ | 24 | $^\circ\text{C/W}$ |
| Maximum Junction-to-Ambient ^A | | Steady-State | 53 | $^\circ\text{C/W}$ |
| Maximum Junction-to-Case ^C | $R_{\theta JC}$ | 2.6 | 3.5 | $^\circ\text{C/W}$ |

Electrical Characteristics (T_J=25°C unless otherwise noted)

| Symbol | Parameter | Conditions | Min | Typ | Max | Units |
|-----------------------------|---------------------------------------|--|-----|----------|----------|-------|
| STATIC PARAMETERS | | | | | | |
| BV _{DSS} | Drain-Source Breakdown Voltage | I _D =250μA, V _{GS} =0V | 30 | | | V |
| I _{DSS} | Zero Gate Voltage Drain Current | V _{DS} =30V, V _{GS} =0V T _J =55°C | | | 1 5 | μA |
| I _{GSS} | Gate-Body leakage current | V _{DS} =0V, V _{GS} = ±12V | | | 100 | nA |
| V _{GS(th)} | Gate Threshold Voltage | V _{DS} =V _{GS} , I _D =250μA | 1 | 1.5 | 2.5 | V |
| I _{D(ON)} | On state drain current | V _{GS} =10V, V _{DS} =5V | 120 | | | A |
| R _{DS(ON)} | Static Drain-Source On-Resistance | V _{GS} =10V, I _D =20A T _J =125°C | | 10 16 | 12 19 | mΩ |
| | | V _{GS} =4.5V, I _D =10A | | 11.5 | 14 | |
| g _{FS} | Forward Transconductance | V _{DS} =5V, I _D =20A | | 49 | | S |
| V _{SD} | Diode Forward Voltage | I _S =1A, V _{GS} =0V | | 0.72 | 1.0 | V |
| I _S | Maximum Body-Diode Continuous Current | | | | 35 | A |
| DYNAMIC PARAMETERS | | | | | | |
| C _{iss} | Input Capacitance | V _{GS} =0V, V _{DS} =15V, f=1MHz | | 1210 | 1452 | pF |
| C _{oss} | Output Capacitance | | | 330 | | pF |
| C _{rss} | Reverse Transfer Capacitance | | | 85 | | pF |
| R _g | Gate resistance | V _{GS} =0V, V _{DS} =0V, f=1MHz | | 1.1 | 1.6 | Ω |
| SWITCHING PARAMETERS | | | | | | |
| Q _g (10V) | Total Gate Charge | V _{GS} =10V, V _{DS} =15V, I _D =20A | | 22 | 28 | nC |
| Q _g (4.5V) | Total Gate Charge | | | 10 | 13 | nC |
| Q _{gs} | Gate Source Charge | | | 3.7 | | nC |
| Q _{gd} | Gate Drain Charge | | | 2.7 | | nC |
| t _{D(on)} | Turn-On DelayTime | V _{GS} =10V, V _{DS} =15V, R _L =0.75Ω, R _{GEN} =3Ω | | 10 | | ns |
| t _r | Turn-On Rise Time | | | 6.3 | | ns |
| t _{D(off)} | Turn-Off DelayTime | | | 21 | | ns |
| t _f | Turn-Off Fall Time | | | 2.8 | | ns |
| t _{rr} | Body Diode Reverse Recovery Time | I _F =20A, dI/dt=100A/μs | | 36 | 45 | ns |
| Q _{rr} | Body Diode Reverse Recovery Charge | I _F =20A, dI/dt=100A/μs | | 47 | | nC |

A: The value of R_{θJA} is measured with the device in a still air environment with T_A=25°C.

B: The power dissipation P_D is based on T_{J(MAX)}=150°C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C: Repetitive rating, pulse width limited by junction temperature T_{J(MAX)}=150°C.

D: The R_{θJA} is the sum of the thermal impedance from junction to case R_{θJC} and case to ambient.

E: The static characteristics in Figures 1 to 6 are obtained using <300 μs pulses, duty cycle 0.5% max.

F: These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T_{J(MAX)}=150°C.

G: These tests are performed with the device mounted on 1 in 2 FR-4 board with 2oz. Copper, in a still air environment with T_A=25°C. The SOA curve provides a single pulse rating.

H: Surface mounted on a 1 in 2 FR-4 board with 2oz. Copper.

J: Maximum current is limited by bonding wire.

Rev8: March 2011

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TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

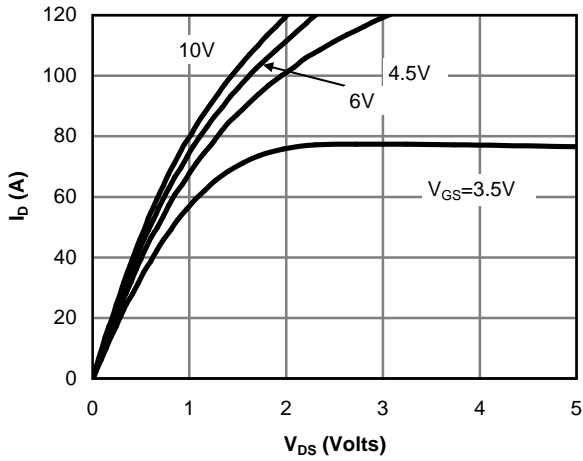


Fig 1: On-Region Characteristics

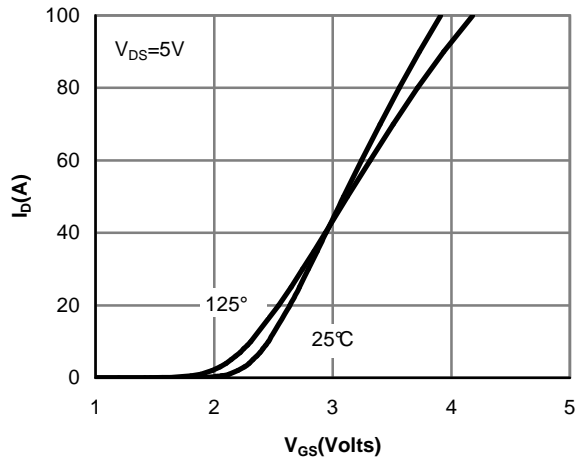


Figure 2: Transfer Characteristics

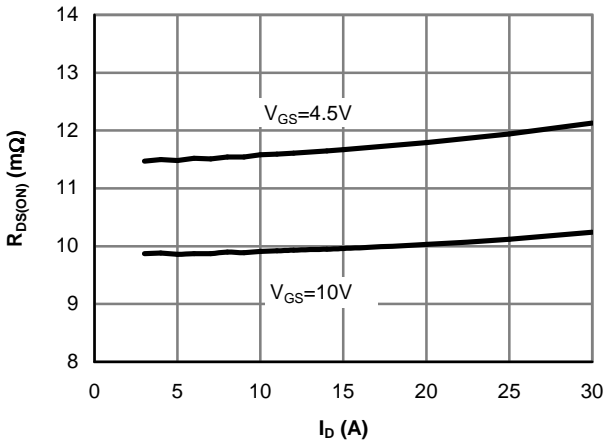


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

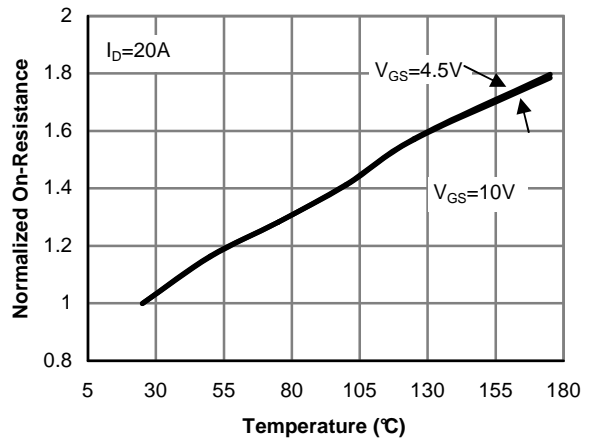


Figure 4: On-Resistance vs. Junction Temperature

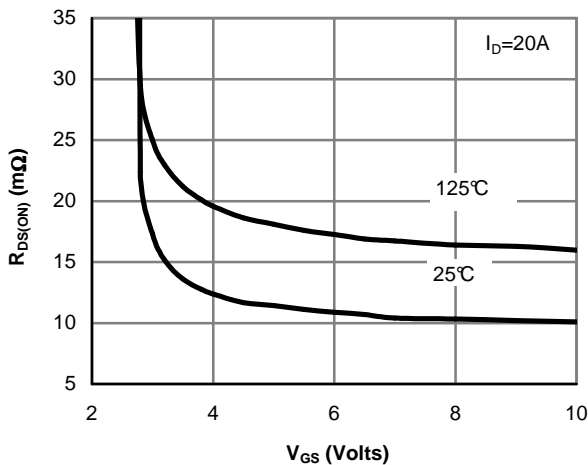


Figure 5: On-Resistance vs. Gate-Source Voltage

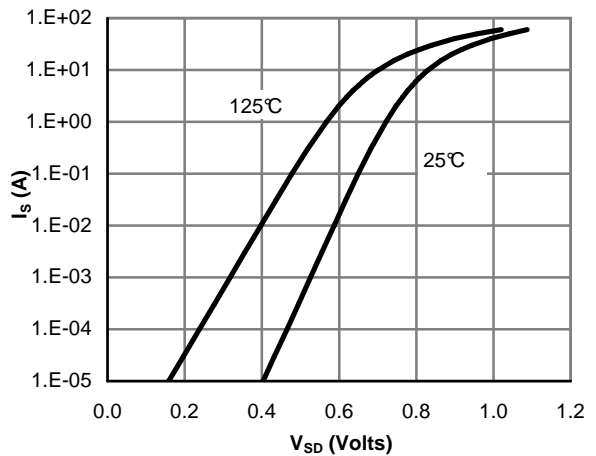


Figure 6: Body-Diode Characteristics

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

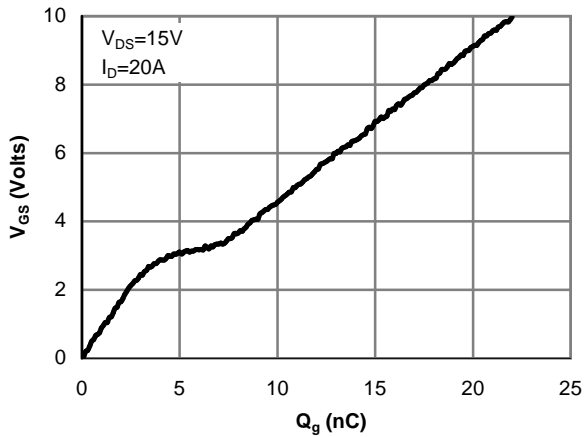


Figure 7: Gate-Charge Characteristics

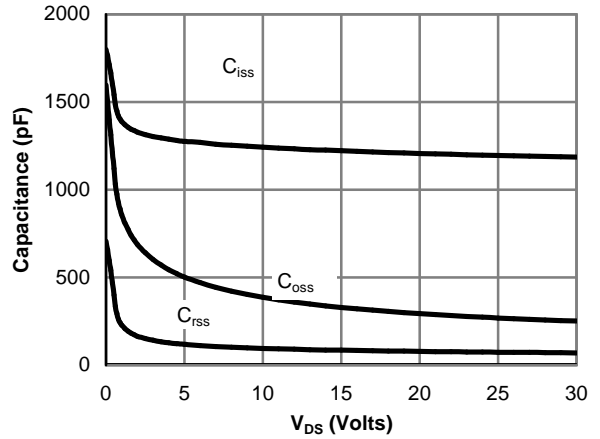


Figure 8: Capacitance Characteristics

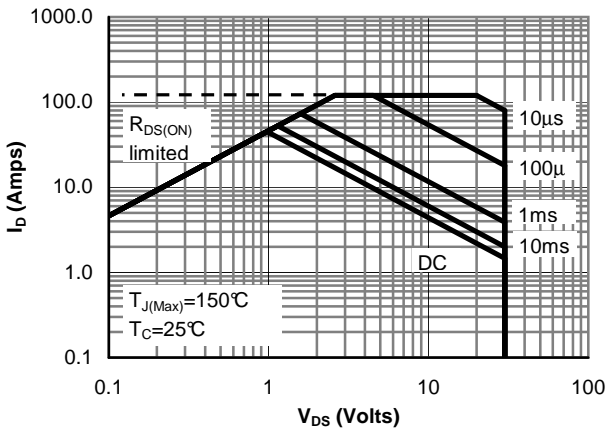


Figure 9: Maximum Forward Biased Safe Operating Area (Note F)

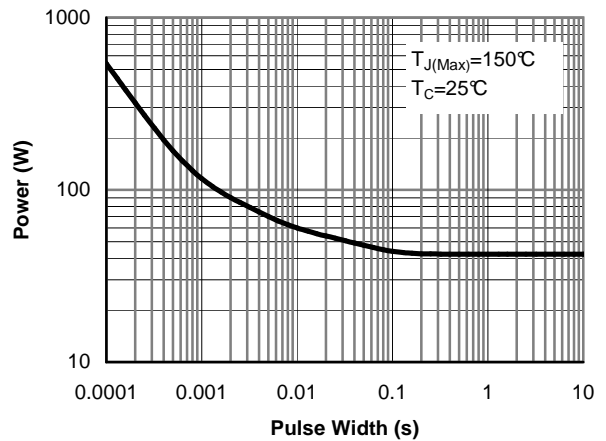


Figure 10: Single Pulse Power Rating Junction-to-Case (Note F)

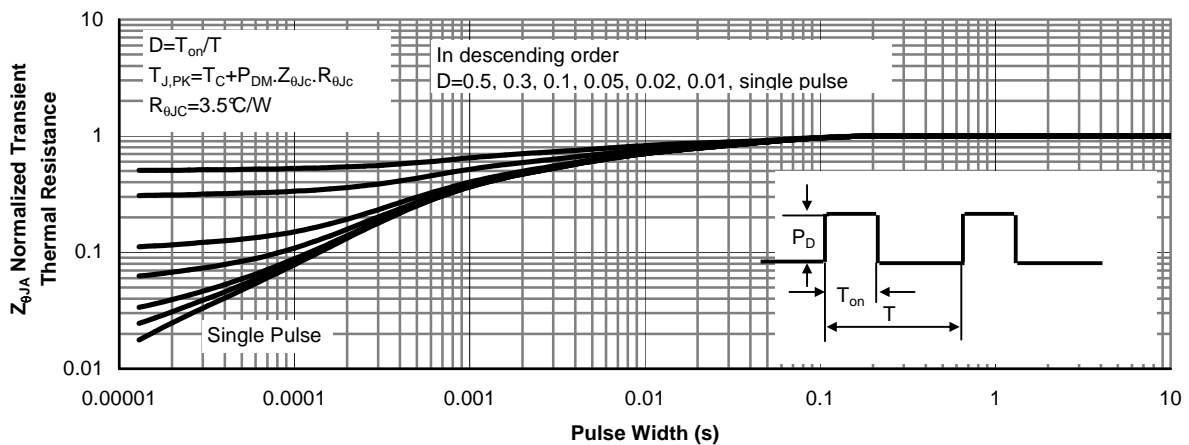


Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

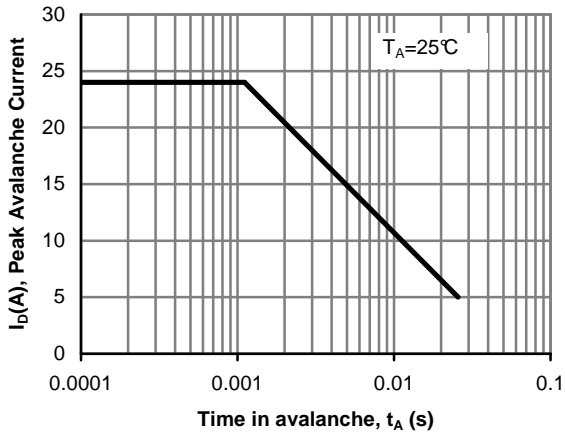


Figure 12: Single Pulse Avalanche capability

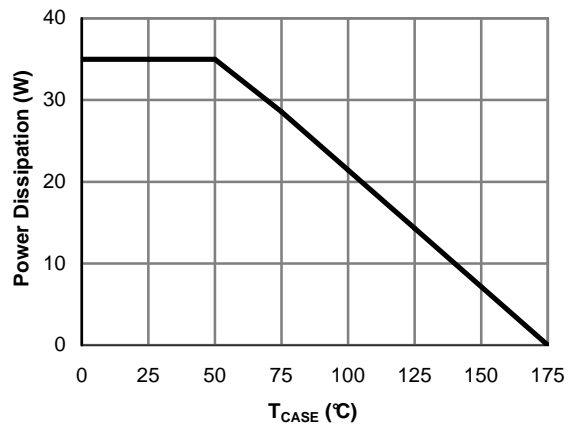


Figure 13: Power De-rating (Note B)

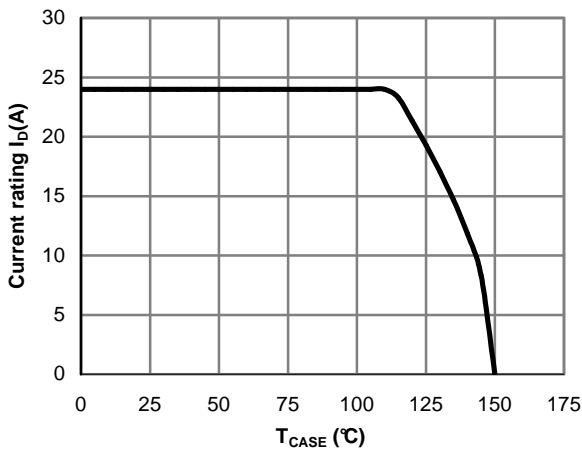


Figure 14: Current De-rating (Note B)

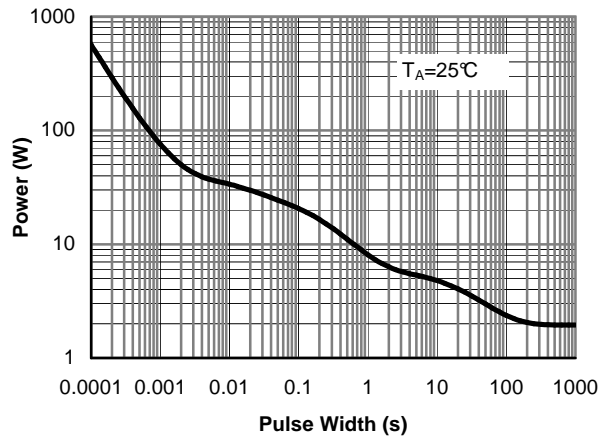


Figure 15: Single Pulse Power Rating Junction-to-Ambient (Note G)

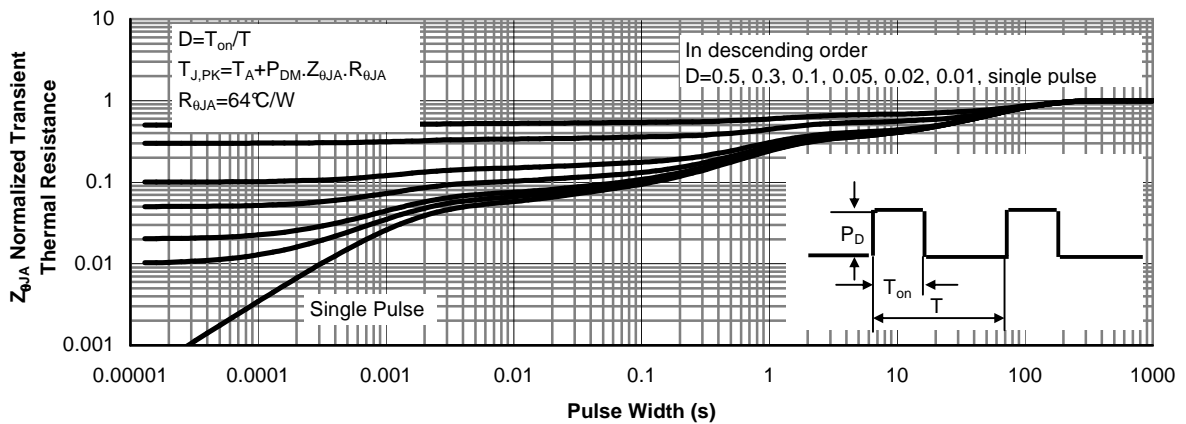
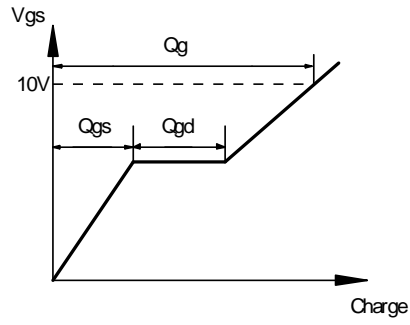
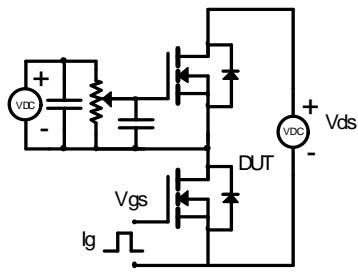
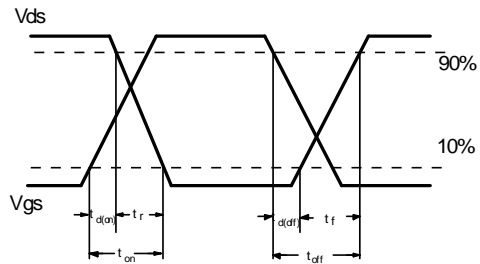
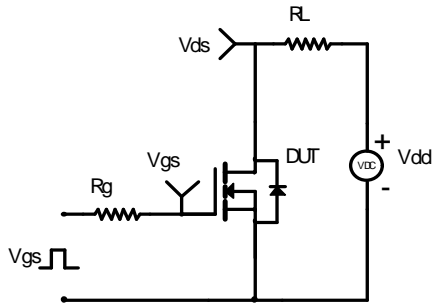


Figure 16: Normalized Maximum Transient Thermal Impedance (Note G)

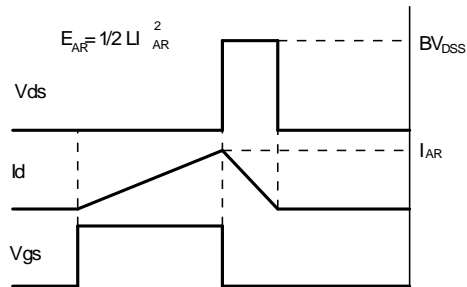
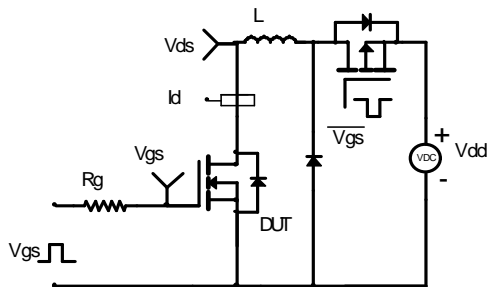
Gate Charge Test Circuit & Waveform



Resistive Switching Test Circuit & Waveforms



Unclamped Inductive Switching (UIS) Test Circuit & Waveforms



#DIV/0! #DIV/0!
#DIV/0! #DIV/0!

Diode Recovery Test Circuit & Waveforms

